

**Search Notes****Application/Control No.**

10/046,304

**Examiner**

Raj K. Jain

**Applicant(s)/Patent under Reexamination**

MORIWAKI ET AL.

**Art Unit**

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (schedul\$4 switch capacity0	3/23/2004	RJ
USPGPUB, USPAT	3/23/2004	RJ
370/230,386,390,398,395.2,395.4 (text search, see printout)	3/23/2004	RJ
370/412,413,422,423,400,428 (text search, see printout)	3/23/2004	RJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner